


Search Notes 	Application/Control No. 10725432	Applicant(s)/Patent Under Reexamination YI ET AL.
	Examiner DJENANE M BAYARD	Art Unit 2444

SEARCHED			
Class	Subclass	Date	Examiner
709	250, 243	7/22/09	db
709	201, 203, 223, 224, 250	1/14/10	db
715	744, 746	1/14/10	db

SEARCH NOTES			
Search Notes		Date	Examiner
east		7/22/09	db
East		1/14/10	db
Double Patenting Search		1/14/10	db
NPL (google Scholar)		1/14/10	db
EIC (FAST and Focus Search)		1/14/10	db

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
709	201, 203, 223, 224, 250	1/14/10	db

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